Yoshiharu ANDA et al.

ATTN: APPLICATION BRANCH

: Docket No. 2003_0955A

Serial No. 10/617,793

THE COMMISSIONER IS AUTHORIZED

TO CHARGE ANY DEFICIENCY IN THE FEES FOR THIS PAPER TO DEPOSIT

ACCOUNT NO. 23-0975

Filed July 14, 2003

SEMICONDUCTOR DEVICE AND MANUFACTURING METHOD THEREOF

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to the provisions of 37 CFR 1.56, 1.97 and 1.98, Applicants request consideration of the references listed on attached form PTO-1449. A legible copy of each reference listed on the form PTO-1449 is enclosed.

1a. [X] This Information Disclosure Statement is submitted:

within three months of the filing date (or of entry into the National Stage) of the above-entitled application, or

before the mailing of a first Office Action on the merits or the mailing of a first Office Action after the filing of an RCE,

and thus no certification and/or fee is required.

1b. [] This Information Disclosure Statement is submitted

after the events of above paragraph 1a and prior to the mailing date of a final Office Action or a Notice of Allowance or an action which otherwise closes prosecution in the application, and thus:

	(1) [] the certification of paragraph 2 below is provided, or								
	(2) [] th	ne fee of \$180.00 specified in 37 CFR 1.17(p) is enclosed.							
1c.	[] This Information Disclosure Statement is submitted:								
	after the mailing date of a final Office Action or Notice of Allowance or action which otherwise closes prosecution in the application, and prior to payment of the issue fee, and thus:								
	the certification of paragraph 2 below is provided, and								
	the fee	of \$180.00 specified in 37 CFR 1.17(p) is enclosed.							
2.	It is hereby certified								
	a. []	that each item of information contained in this Information Disclosure Statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of the Statement, or							
	b. []	that no item of information contained in the Information Disclosure Statement was cited in a communication from a foreign patent office in a counterpart foreign application and, to the knowledge of the person signing the certification after making reasonable inquiry, was known to any individual designated in §1.56(c) more than three months prior to the filing of the Statement.							
3. []	Consideration of the following list of additional information (including any copending of abandoned U.S. application, prior uses and/or sales, etc.) is requested.								
4.	For each non-English language reference listed on the attached form PTO-1449, reference is made to:								

a full or partial English language translation submitted herewith,

a foreign patent office search report (in the English language) submitted herewith,

a. []

b. []

- c. [X] the concise explanation for reference (AJ) is contained in the specification of the present application at page 2,
- d. [X] the concise explanation set forth in the attached English language abstracts,
- e. [] the concise explanation set forth below or on a separate sheet attached to the reference:
- 5. [] A foreign patent office search report citing one or more of the references is enclosed.

Respectfully submitted,

Yoshiharu ANDA et al.

By Michael S. Huppert

Registration No. 40,268

Attorney for Applicants

MSH/kjf Washington, D.C. 20006-1021 Telephone (202) 721-8200 Facsimile (202) 721-8250

September 15, 2003

Sheet 1 of 1	.6	•										
FORM PTO 1449 (<i>modified</i>) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S)				ATTY DOCKET NO. 2003_0955A								
				APPLICANT Yoshiharu ANDA et al.				SEP 1 5 20	9			
		eral sheets if necessary) to PTO: September 15,	, 2003	FILING DATE July 14, 2003			GROUP	TRADEN	MARKO			
U.S. PATENT DOCUMENTS												
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CL	LASS	SUBCLASS	FILING DA APPROPE				
	AA											
	АВ	~~~	<u> </u>									
	AC											
	AD											
	AE		!									
	AF											
	AG											
	АН		!									
	AI											
	, , ,		FORF	EIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY	CL.	.ASS	SUBCLASS	TRANSLA YES	ATION NO			
	AJ	9-45894	2/1997	JP				Abstract				
	AK	61-91966	5/1986	JP				Abstract				
	AL	63-169064	7/1988	JP				Abstract				
	АМ	63-299164	12/1988	JP				Abstract				
	AN											
	 	OTHER C	OCUMENT(S) (Inc	cluding Author, Title, Date, Perti	inent Page	s, Etc.)		-				
	AO											
	АР											
	AQ.											
EXAMINER				DATE CONSIDERED								

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.